



Algorithm Method for Chemical Analysis Elemental by WDXRF Technique

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1. Introduction

X-ray fluorescence spectrometry (XRFS) is an instrumental analytical technique used to identify and quantify elements in geological, nuclear, environmental, forensic samples and others [1-6]. The quantitative results in terms precision and accuracy are satisfactory by calibration curve method using certified reference materials (CRMs). The calibration curve method is used to minimize inter-element effects (the matrix effect), but is often expensive. [7-8]. Mathematical methods have been proposed to minimize these costs, e.g., the Fundamental Parameters Method and the Algorithms Method [9]. Currently, mathematical models such as Back Propagation (BP), Radial Basis Function (RBF), Self-Generator Neural Network (SGNN) and Network Hopfield are being used in artificial intelligence for chemical analysis. The models show nonlinear data processing efficiency; however, improvements are needed for X-ray fluorescence spectrometry applications [10].

Therefore, this study aimed to measure the continuous spectrum for the element's boron (⁵B) to uranium (⁹²U) using a wavelength dispersive X-ray fluorescence spectrometer (WDXRF). Furthermore, evaluate through mathematical fitting the area of continuous spectra and relate them to the respective elements. Subsequently, to relate the area values obtained for each element with the tabulated physical parameters (fluorescence yield, attenuation coefficient, among others), and finally, to build an instrumental sensitivity curve to quantify major and minor elements without using a calibration curve.

2. Methodology

The experiments were carried out using a Rigaku Co. (Tokyo, Japan) wavelength dispersive X-ray fluorescence spectrometer (WDXRF) model RIX 3000, with an Rh-anode X-ray tube, 75 μm Be windows, a 60 kV maximum acceleration voltage generator, NaI (TI) scintillation detectors, and a gas-flow proportional counter.

The 2-theta-scan mode was used with a sample holder of 20 mm Ø area. The spectrum of each element was obtained by compounds and metals of analytical grade measuring, e.g, H₃BO₃, C₃H₆, Na₂CO₃, Mg⁰, Al⁰, SiO₂, Ca₃(PO₄)₂, Ti⁰, Ni⁰, Cu⁰, Zn⁰, Ag⁰, Pb⁰ ... U₃O₈. The software coupled to WDXRF was used to subtract background (BG) from the original spectrum.

Thus, were obtained two spectra: spectrum A with the characteristic lines and BG and spectrum B with the characteristic lines without BG.

The count rate (kcps) versus 2-theta (for 4,250 points) were transferred to a spreadsheet (Microsoft Excel 2013). Afterward, spectrum A was subtracted from spectrum B, resulting in spectrum C (continuous spectrum).

The Gauss-Amp fit model was applied in spectrum C (kcps versus 2-theta) for area calculation using Origin Pro 8 software.

The area of continuous spectrum of each element were related to their respective atomic numbers. Two fitting models were used to evaluate the correlation: second-degree polynomial fitting and third-degree polynomial fitting using Origin Pro 8 software.

The certified reference material (CRM) stainless steel 304 L (British Chemical Standards - BCS. 463) was analyzed to assess the method, using Eq. 1.

$$C_i = \frac{AP_i * AC_i * CFI_i}{\sum CS_i} \times 100 \quad (1)$$

Where: C_i = concentration element (i); AP_i = peak area element (i); AC_i = area of continuous spectrum calculated of element (i); CFI = sum following parameters: fluorescence yield, X-Ray mass attenuation coefficients, and Edge absorption element (i); $\sum CS_i$ = sum of AP_i , AC_i , and CFI for all elements analyzed.

3. Results and Discussion

The Fig. 1 (A) show continuous spectrum by WDXRF and Fig. 1(B) the continuous spectrum after GaussAmp fitting for ^{12}Mg , ^{14}Si , ^{20}Ca , ^{26}Fe , ^{40}Zr , and ^{92}U . The increase in X-rays absorption is observed in both cases.

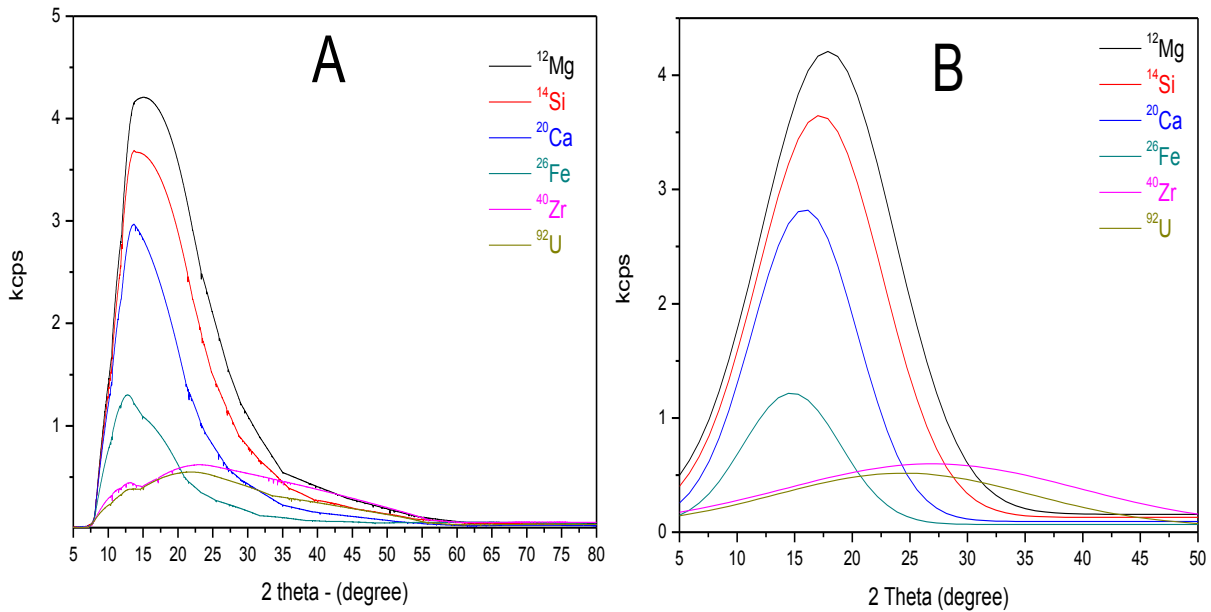


Figure 1: continuous spectrum for WDXRF (A) and continuous spectrum after GaussAmp fitting (B).

The Fig. 2 shows area (kcps - GaussAmp fitting) versus elements (Mg, Al, Si, Ca, Sc, Ti, V, Cr, Mn, Fe, Co, Ni, Cu, Zn, Ga, As, Y, Zr, Nb, Mo, Cd, In, Sn, La, Hf, Ta, Hg, Pb, Bi, Th and U) by second-degree polynomial fitting;. Correlation ($R^2 \approx 0.77$).

The Fig. 3 shows area (kcps - GaussAmp fitting) versus elements (Mg, Al, Si, Ca, Sc, Ti, V, Cr, Mn, Fe, Co, Ni, Cu, Zn, Ga, As, Y, Zr, Nb, Mo, Cd, In, Sn, La, Hf, Ta, Hg, Pb, Bi, Th and U) by third-degree polynomial fitting;. Correlation ($R^2 \approx 0.90$).

Figure 2: area versus elements - second-degree polynomial fitting

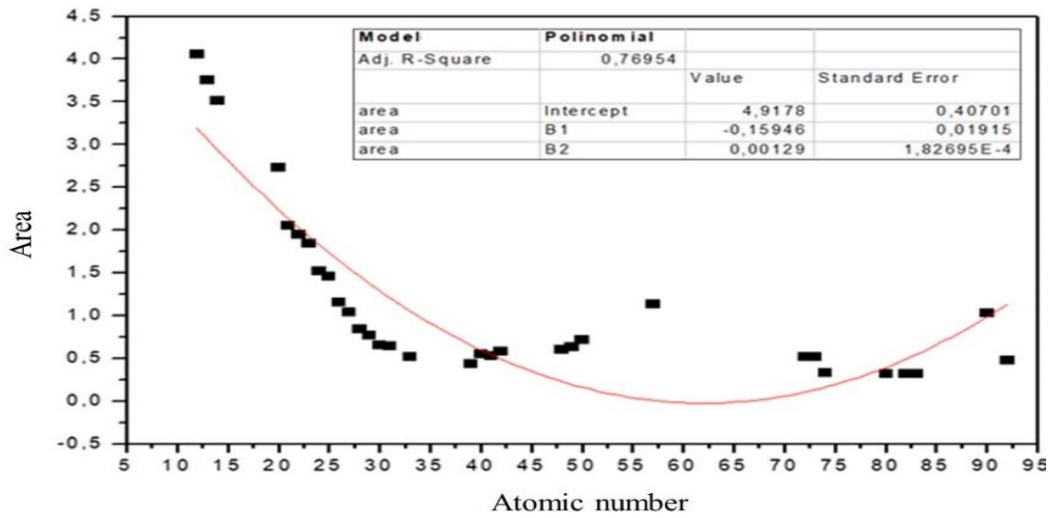
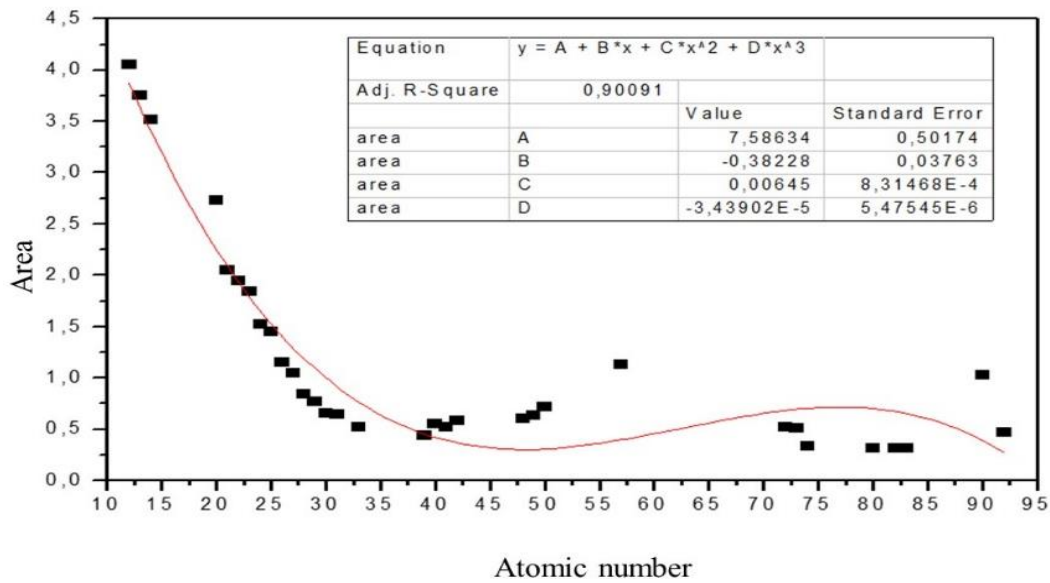


Figure 3: area versus elements - third-degree polynomial fitting



The certified ($\bar{X} \pm \sigma$) and determined content using Eq. 1 and (\bar{D}), relative error (RE%), Z-score test (Z-score) and tabulated values for fluorescence yield (φ), X-Ray mass attenuation coefficients (μ_m), Edge absorption (μ_E) are presented in Table I.

Table I: Parameters certified and determined for MCR 463 (WDRFX).

Elemento	$\bar{X} \pm \sigma$ (%)	\bar{D} (%)	RE%	Z - Score	φ	μ_m	μ_E
Fe	70.7±0.1	73±2	3.2	1.1	0.340	0.408	7.111
Cr	18.29±0.05	17±1	7	1.3	0.283	0.598	5.989
Ni	9.65±0.05	9.3±0.3	4	1.2	0.410	0.329	8.332
Mn	0.77±0.02	0.54±0.02	43	8.1	0.313	0.452	6.538
Si	0.51±0.01	0.020±0.001	2892	48.8	0.043	0.003	1.840
P	0.015±0.001	0.0070±0.0002	124	7.8	0.060	0.002	24

Accuracy in terms RE% is satisfactory since the Z-Score values <2 for Fe, Cr, and Ni (major contents). Z-Score for Mn, Si and P (minor contents) unsatisfactory since Z-Score >2.

Conclusions

The quantitative analysis model for stainless steel 304 L without calibration curve showed in this work it's appropriate. The proposing methodology is a promising way to collaborating with improvement of nonlinear data processing efficiency applied artificial intelligence for chemical analysis.

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References

- [1] SCAPIN, M.A.; TESSARI-ZAMPIERI, M.C.; GUILHEN, S.N.; COTRIM, M. E. B. X-ray fluorescence spectrometry: An alternative technique for analysis of waste. *Brazilian Journal of Radiation Science*, vol. 11-01A, pp. 01-08, (2023).
- [2] SCAPIN, M. A.; SILVA, C.P.; COTRIM, M. E. B.; PIRES, M. A.F. Application of multivariate calibration for simultaneous determination of major and minor constituents in U₃Si₂ by X-ray fluorescence. *Journal of Radioanalytical and Nuclear Chemistry*, vol. 302, pp. 1077-1085, (2014).
- [3] SILVA, P. S.C; MÁDUAR, M. F.; SCAPIN, M. A.; GARCIA, R. H. L.; MARTINS, J. P.M. Radiological assessment of pharmaceutical clays. *Journal of Radioanalytical and Nuclear Chemistry*, vol. 307, pp. 2035-2046, (2016).
- [4] LIU, W., ZHAO, J. DU, L.; PADWAL, H.H.; VADIVEL, T. Intelligent comprehensive evaluation system using artificial intelligence for environmental evaluation. *Environmental Impact Assessment Review*, vol. 86, n. 106495, pp. 1-8, (2021).
- [5] WANG et al., 2021; WANG, Y.; YU, T.; YANG, Z.; BO, H.; LIN, Y., YANG, Q.; ZHANG, Q.; ZHUO, X.; WU, T. Zinc concentration prediction in rice grain using back-propagation neural network based on soil properties and safe utilization of paddy soil: A large-scale field study in Guangxi, China. *Science of the Total Environment*, vol. 798, n. 149270, pp. 1-11, (2021).
- [6] TESSARI-ZAMPIERI, M.C.; CONTRIM, E.B.; SCAPIN, M.A. Fingerprint of Precious Metals Ornaments to PostMortem Inventory by Energy Dispersive X-Ray Fluorescence Spectrometry. *International Journal of Science and Research*.vol.12, n. 7942, (2023).
- [7] WILLIAMS, K.L. Introduction to X-ray spectrometry. London, Allen & Unwin, (1987).
- [8] SANTOS, E.S.; GAMA, E.M.; FRANÇA, R.S.; SOUZA, A.S.; MATOS, R.P. Espectrometria de fluorescência de raios-X na determinação de espécies químicas. *ENCICLOPÉDIA BIOSFERA*, Centro Científico Conhecer – Goiânia, vol.9, n.17, (2013).
- [9] CRIS and BIRKS, 1969 CRISS, J. W.; BIRKS, L.S. Calculation methods for fluorescent X-ray spectrometry empirical coefficients vs. fundamental parameters. *Analytical Chemistry*, vol. 40, pp. 1080-1086, (1969). Disponível em: < <https://pubs.acs.org/doi/pdf/10.1021/ac60263a023> > Acesso em: 19 nov. 2021.
- [10] KANIU, M.I.; ANGEYO, K.H.; MWALA, A.K.; MANGALA, M.J. Direct rapid analysis of trace bioavailable soil macronutrients by chemometrics-assisted energy dispersive X-ray fluorescence and scattering spectrometry. *Analytica Chimica Acta*, v. 729, p. 21-25, 2012.